

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/747,983	WAYAMA ET AL.	
Examiner	Art Unit	John T. Kwon	3747

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0231644	11-2004	Ikeda et al.	123/399
	B	US-2004/0194757	10-2004	Irihune et al.	123/399
	C	US-6,819,102	11-2004	Hagio et al.	324/207.25
	D	US-6,756,780	06-2004	Hagio et al.	324/207.25
	E	US-6,701,892	03-2004	Wayama et al.	123/399
	F	US-6,407,543	06-2002	Hagio et al.	324/207.25
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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